

Notice of References Cited	Application/Control No. 09/845,284	Applicant(s)/Patent Under Reexamination MOCHIZUKI ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0079583	05-2003	FUNAKOSHI et al.	83/13
	B	US-			
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	D	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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*	N	EP 993038	04-2000	European	Watanabe et al	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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